

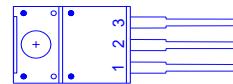
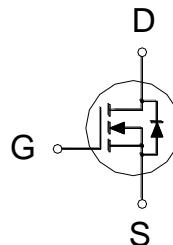
**NIKO-SEM****N-Channel Enhancement Mode  
Field Effect Transistor****PG8E10AF**

TO-220F

Halogen-Free &amp; Lead-Free

**PRODUCT SUMMARY**

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D$
100V	8.5mΩ	43A



1. GATE
2. DRAIN
3. SOURCE

**ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$  Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		$V_{DS}$	100	V
Gate-Source Voltage		$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$T_C = 25^\circ\text{C}$	$I_D$	47	A
	$T_C = 100^\circ\text{C}$		33	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	200	A
Avalanche Current		$I_{AS}$	20	
Avalanche Energy	$L = 1\text{mH}$	$E_{AS}$	200	mJ
Power Dissipation	$T_C = 25^\circ\text{C}$	$P_D$	45	W
	$T_C = 100^\circ\text{C}$		22	
Junction & Storage Temperature Range		$T_J, T_{stg}$	-55 to 175	°C

**THERMAL RESISTANCE RATINGS**

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		3.3	°C / W
Junction-to-Ambient	$R_{\theta JA}$		62.5	

<sup>1</sup>Pulse width limited by maximum junction temperature.

**ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Noted)**

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	100			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2	3	4	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			$\pm 100$	nA

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Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 100V, V_{GS} = 0V$			1	$\mu A$
		$V_{DS} = 100V, V_{GS}=0V, T_J=125\text{ }^{\circ}\text{C}$			100	
Drain-Source On-State Resistance <sup>1</sup>	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 14A$		6.6	8.5	$m\Omega$
Forward Transconductance <sup>1</sup>	$g_{fs}$	$V_{DS} = 5V, I_D = 14A$		44		S
<b>DYNAMIC</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0V, V_{DS} = 50V, f = 1MHz$		3509		$pF$
Output Capacitance	$C_{oss}$			293		
Reverse Transfer Capacitance	$C_{rss}$			19		
Gate Resistance	$R_g$	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		1.6		$\Omega$
Total Gate Charge <sup>2</sup>	$Q_g$	$V_{DS} = 50V, I_D = 14A,$ $V_{GS} = 10V$		55		$nC$
Gate-Source Charge <sup>2</sup>	$Q_{gs}$			17		
Gate-Drain Charge <sup>2</sup>	$Q_{gd}$			15		
Turn-On Delay Time <sup>2</sup>	$t_{d(on)}$	$V_{DD} = 50V$ $I_D \cong 14A, V_{GS} = 10V, R_{GS} = 6\Omega$		23		$nS$
Rise Time <sup>2</sup>	$t_r$			48		
Turn-Off Delay Time <sup>2</sup>	$t_{d(off)}$			48		
Fall Time <sup>2</sup>	$t_f$			38		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (<math>T_J = 25\text{ }^{\circ}\text{C}</math>)</b>						
Continuous Current	$I_S$				37	A
Forward Voltage <sup>1</sup>	$V_{SD}$	$I_F = 14A, V_{GS} = 0V$			1.2	V
Reverse Recovery Time	$t_{rr}$	$I_F = 14A, dI_F/dt = 100A / \mu S$		43		$nS$
Reverse Recovery Charge	$Q_{rr}$			71		$nC$

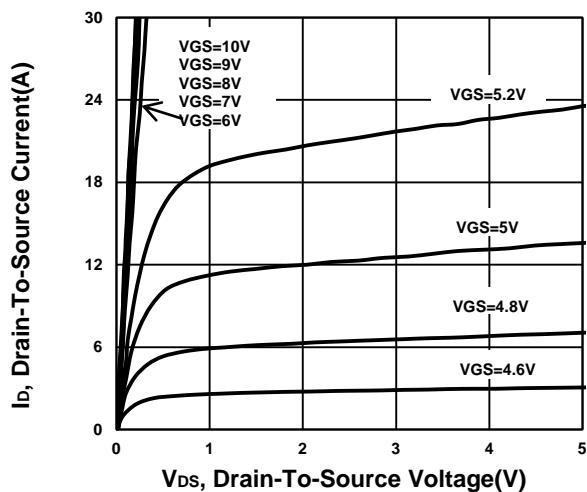
<sup>1</sup>Pulse test : Pulse Width  $\leq 300\text{ }\mu\text{sec}$ , Duty Cycle  $\leq 2\%$ .<sup>2</sup>Independent of operating temperature.

**NIKO-SEM**

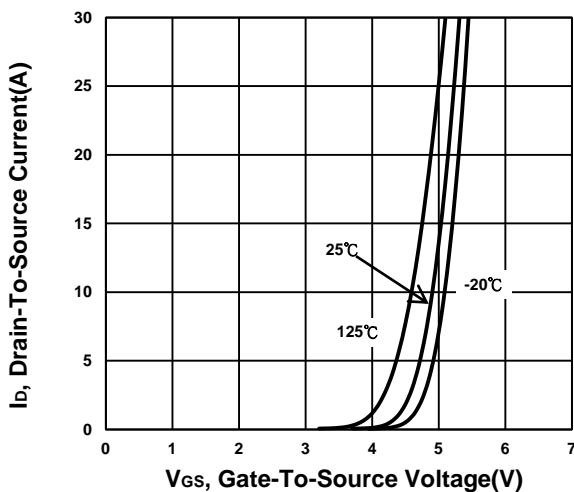
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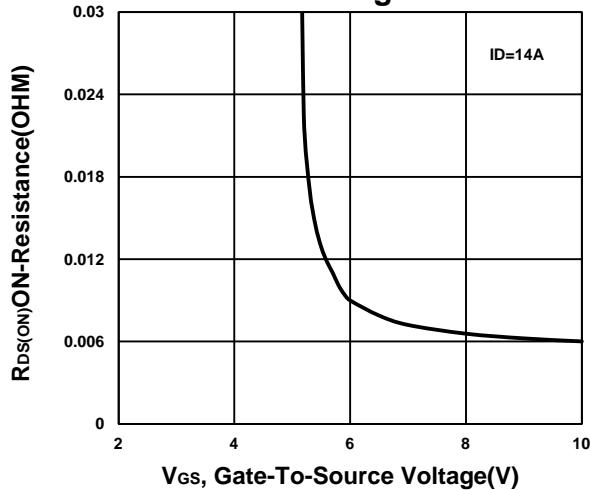
### Output Characteristics



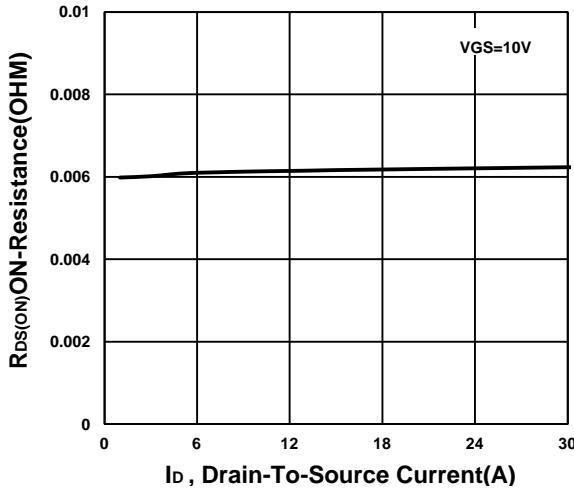
### Transfer Characteristics



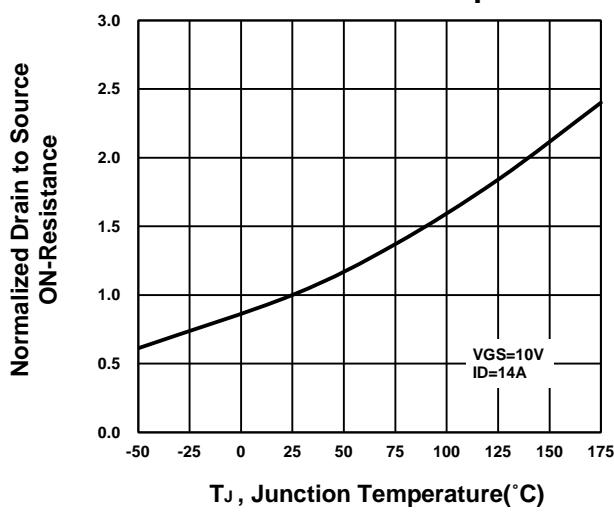
### On-Resistance VS Gate-to-Source Voltage



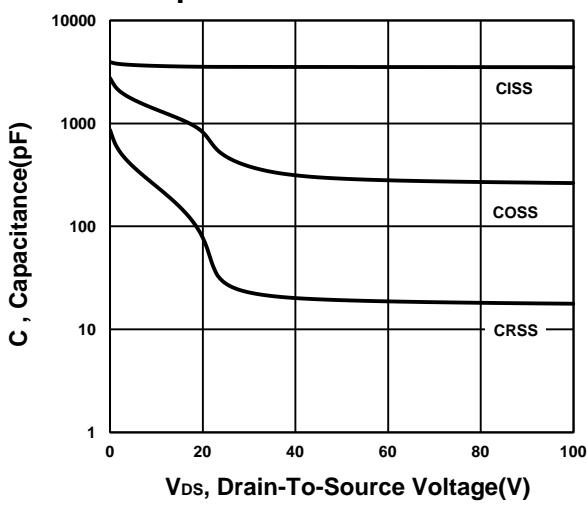
### On-Resistance VS Drain Current

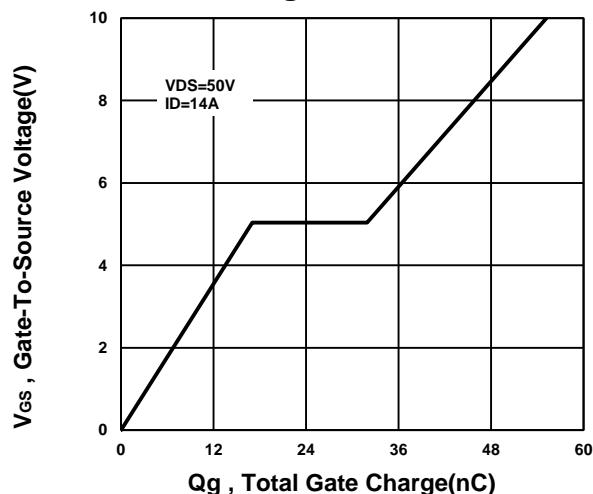
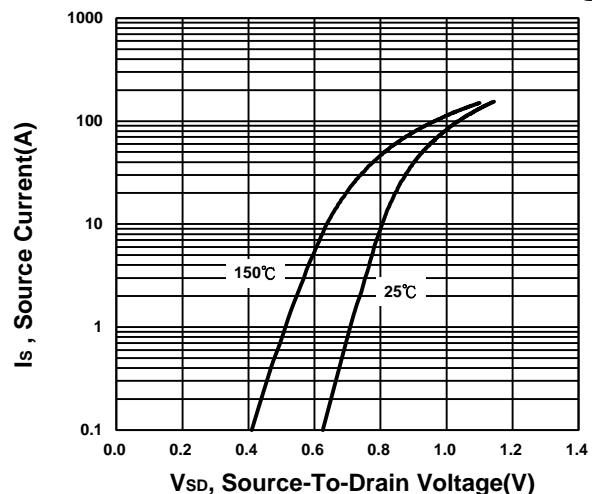
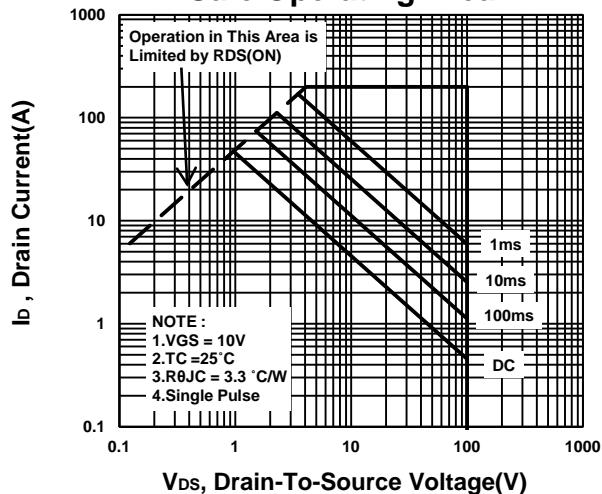
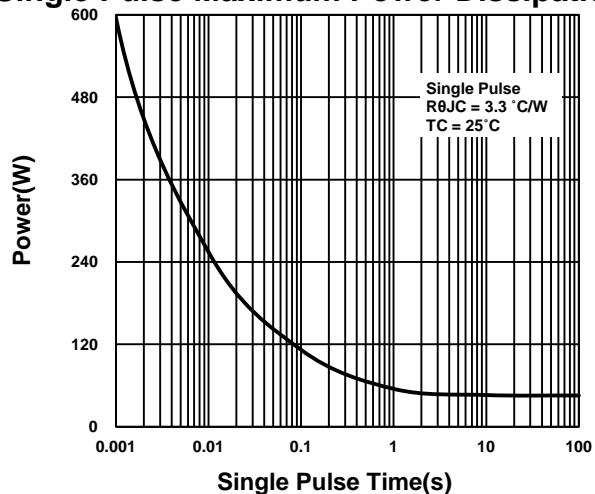


### On-Resistance VS Temperature



### Capacitance Characteristic



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Halogen-Free & Lead-Free****Gate charge Characteristics****Source-Drain Diode Forward Voltage****Safe Operating Area****Single Pulse Maximum Power Dissipation****Transient Thermal Response Curve**